## Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/563,372	Reexamination UPHOFF, CHRIS	TIAN
Examiner	Art Unit	
NATHAN A BOWERS	1797	Page 1 of 1

## U.S. PATENT DOCUMENTS

	U.S. I AIEN DOGSMENTS				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0067159	04-2004	Carnes et al.	422/028
*	В	US-6,932,947	08-2005	Leung, Chan Ming	422/186.3
*	С	US-6,403,366	06-2002	Kim, Byung Joon	435/266
*	D	US-6,379,433	04-2002	Scranton, Jr., Delbert C.	95/135
*	Е	US-5,817,504	10-1998	Lasky et al.	435/262.5
*	F	US-6,171,853	01-2001	Kim, Byung Joon	435/299.1
	G	US-		-	
	Н	US-			
		US-			
	J	US-			
	К	US-			
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## NON DATENT DOCUMENTS

* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U		
	v		
	w		
	x		

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.